

Notice of References Cited	Application/Control No. 10/670,089	Applicant(s)/Patent Under Reexamination CHEN, CHUN TSUN	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,508,567	01-2003	Fiene, Dale E.	362/147
	B	US-6,217,190	04-2001	Altman et al.	362/221
	C	US-6,194,840	02-2001	Chang, Chin	315/209R
	D	US-6,164,797	12-2000	Crane et al.	362/221
	E	US-6,146,170	11-2000	Fumin, Guan	439/236
	F	US-5,580,158	12-1996	Aubrey et al.	362/226
	G	US-5,260,678	11-1993	Van Wagener et al.	336/96
	H	US-5,226,724	07-1993	Kanarek, Shepard S.	362/260
	I	US-5,177,404	01-1993	Cohen et al.	315/154
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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